Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination NAKAGAWA ET AL.	
TUAN A. PHAM	2618	

SEARCHED					
Class	Subclass	Date	Examiner		
455	561.1	4/5/2007	PHAM		
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	11.1	4/7/2007	PHAM		
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INTERFERENCE SEARCHED					
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Nguyen Vo	4/7/2007	PHAM
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